International IOR Rectifier

POWER MOSFET SURFACE MOUNT(SMD-1)

Product Summary

Part Number	RDS(on)	ID
IRFN340	0.55 Ω	10A

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.





Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Surface Mount
- Dynamic dv/dt Rating
- Light-weight

Absolute Maximum Ratings

	Parameter		Units	
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	10		
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current	6.0	Α	
IDM	Pulsed Drain Current ①	40	40	
P _D @ T _C = 25°C	Max. Power Dissipation	125	W	
	Linear Derating Factor	1.0	W/°C	
VGS	Gate-to-Source Voltage	±20	V	
EAS	Single Pulse Avalanche Energy ②	650	mJ	
IAR	Avalanche Current ①	10	Α	
EAR	Repetitive Avalanche Energy ①	12.5	mJ	
dv/dt	Peak Diode Recovery dv/dt 3	4.0	V/ns	
ТЈ	Operating Junction	-55 to 150		
TSTG Storage Temperature Range			°C	
	Package Mounting Surface Temperature	300(for 5 seconds)		
	Weight	2.6 (Typical)	g	

For footnotes refer to the last page

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

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	Parameter	Min	Тур	Max	Units	Test Conditions	
BVDSS	Drain-to-Source Breakdown Voltage	400	_	_	V	$V_{GS} = 0V$, $I_{D} = 1.0 \text{mA}$	
ΔBVDSS/ΔTJ	Temperature Coefficient of Breakdown Voltage	_	0.46	_	V/°C	Reference to 25°C, I _D = 1.0mA	
R _D S(on)	Static Drain-to-Source On-State	_		0.55	Ω	V _{GS} = 10V, I _D = 6.0A	
	Resistance	_	_	0.70	32	VGS = 10V, ID = 10A	
VGS(th)	Gate Threshold Voltage	2.0		4.0	V	V _{DS} = V _{GS} , I _D = 250μA	
9fs .	Forward Transconductance	4.9	_	_	S	V _{DS} =15V, I _{DS} = 6.0A ⊕	
IDSS	Zero Gate Voltage Drain Current	_	_	25	μА	VDS= 320V ,VGS=0V	
		_	_	250	μΑ	V _{DS} = 320V,	
						$V_{GS} = 0V$, $T_{J} = 125$ °C	
IGSS	Gate-to-Source Leakage Forward	_	_	100	nA	VGS = 20V	
IGSS	Gate-to-Source Leakage Reverse	_	_	-100	nA	V _{GS} = -20V	
Qg	Total Gate Charge		_	65		VGS =10V, ID = 10A	
Qgs	Gate-to-Source Charge	_	_	14	nC	VDS = 200V	
Q _{gd}	Gate-to-Drain ('Miller') Charge	_	_	40.5			
^t d(on)	Turn-On Delay Time	_	_	25		$V_{DD} = 200V, I_D = 10A,$	
t _r	Rise Time	_	_	92	ns	$V_{GS} = 10V$, $R_{G} = 2.35\Omega$	
^t d(off)	Turn-Off Delay Time	_		79	115		
tf	Fall Time	_	_	58			
LS+LD	Total Inductance	_	4.0	_	nH	Measured from the center of drain	
						pad to center of source pad.	
C _{iss}	Input Capacitance		1400	_		$V_{GS} = 0V, V_{DS} = 25V$	
Coss	Output Capacitance	_	3500	_	pF	f = 1.0MHz	
C _{rss}	Reverse Transfer Capacitance	_	2300	_			

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
Is	Continuous Source Current	(Body Diode)	_	_	10	۸	
ISM	Pulse Source Current (Body	Diode) ①	_	_	40	Α	
VSD	Diode Forward Voltage		_	_	1.5	V	$T_j = 25$ °C, $I_S = 10A$, $V_{GS} = 0V$ ④
trr	Reverse Recovery Time		_	_	600	ns	Tj = 25°C, IF = 10A, di/dt ≤ 100A/μs
QRR	Reverse Recovery Charge		_	_	5.6	μC	V _{DD} ≤ 30V ④
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by LS + LD.					

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	_	_	1.0	°C/W	
R _{thJ-PCB}	Junction-to-PC board	_	4.0	_	C/VV	Soldered to a copper-clad PC board

Note: Corresponding Spice and Saber models are available on International Rectifier Web site.

For footnotes refer to the last page

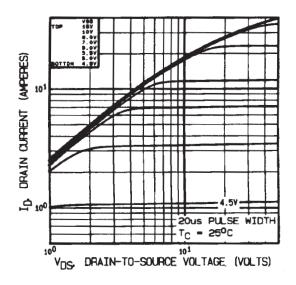


Fig 1. Typical Output Characteristics

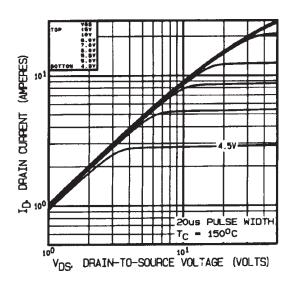


Fig 2. Typical Output Characteristics

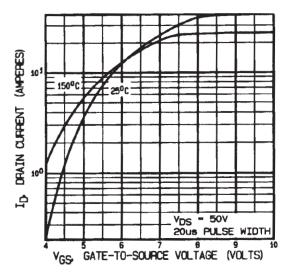


Fig 3. Typical Transfer Characteristics

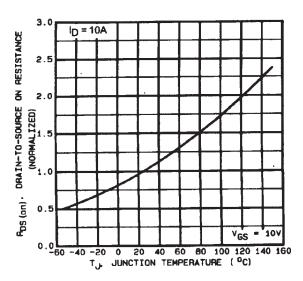


Fig 4. Normalized On-Resistance Vs. Temperature

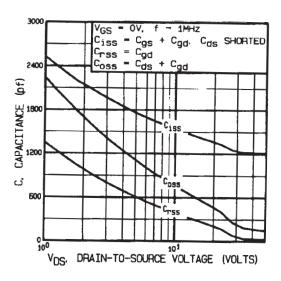


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

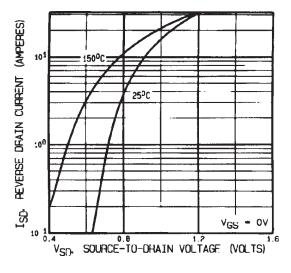


Fig 7. Typical Source-Drain Diode Forward Voltage

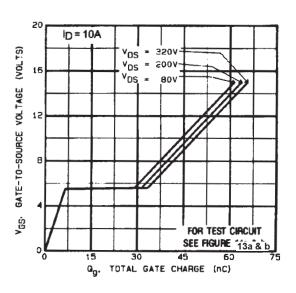


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

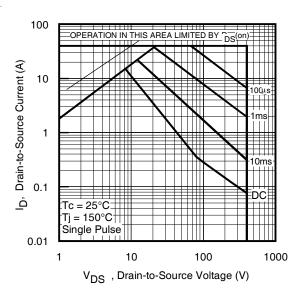


Fig 8. Maximum Safe Operating Area

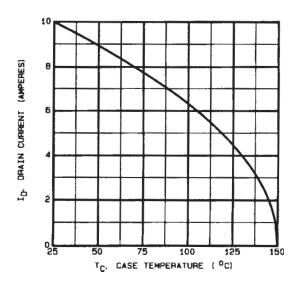


Fig 9. Maximum Drain Current Vs. Case Temperature

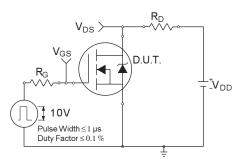


Fig 10a. Switching Time Test Circuit

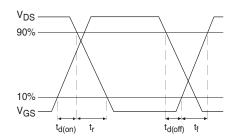


Fig 10b. Switching Time Waveforms

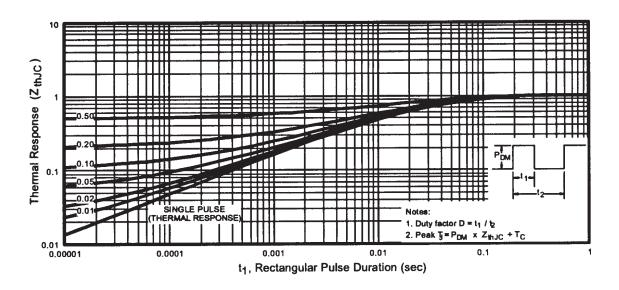


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

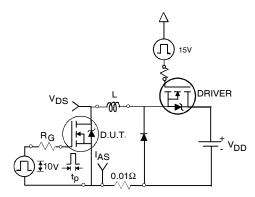


Fig 12a. Unclamped Inductive Test Circuit

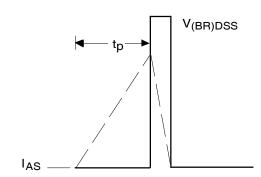


Fig 12b. Unclamped Inductive Waveforms

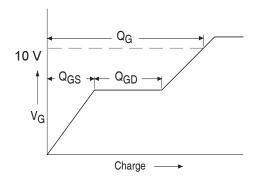


Fig 13a. Basic Gate Charge Waveform

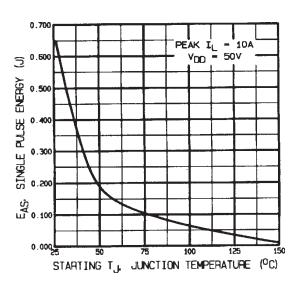


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

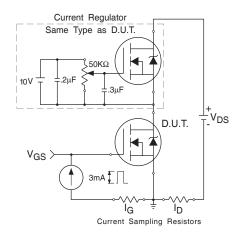


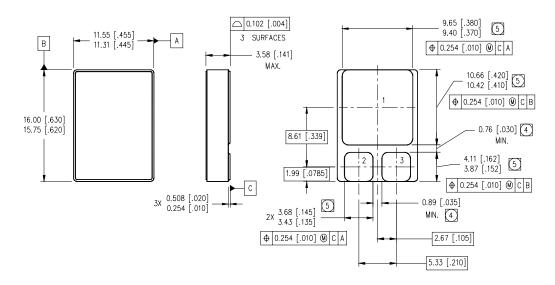
Fig 13b. Gate Charge Test Circuit

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Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $^{\circ}$ V_{DD} = 50V, starting T_J = 25°C, L= 13mH Peak I_L = 10A, V_{GS} = 10V
- $\label{eq:interpolation} \begin{array}{ll} \text{ (3)} & I_{SD} \leq 10\text{A, di/dt} \leq 120\text{A/}\mu\text{s,} \\ & V_{DD} \leq 400\text{V, TJ} \leq 150^{\circ}\text{C} \\ \end{array}$
- 4 Pulse width \leq 300 μ s; Duty Cycle \leq 2%

Case Outline and Dimensions — SMD-1



NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4 DIMENSION INCLUDES METALLIZATION FLASH.
- 5) DIMENSION DOES NOT INCLUDE METALLIZATION FLASH.

PADASSIGNMENTS

- 1- DRAIN
- 2- GATE
- 3- SOURCE

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Data and specifications subject to change without notice. 03/2011